美浦森半导体
M s e m i t e k

RoHS
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SLV8205L
16V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

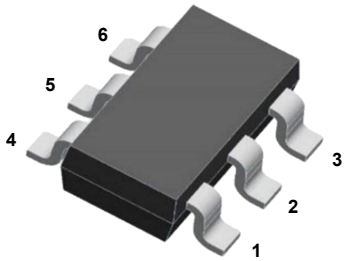
Features

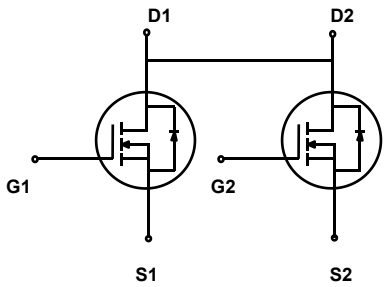
- N-Channel: 16V 4A
  $R_{DS(on)Typ}$=22mΩ@V_{GS} = 4.5 V
  $R_{DS(on))Typ}$= 34mΩ@V_{GS} = 2.5V
- Very Low On-resistance $R_{DS(ON)}$
- Low Crss
- Fast switching
- Improved dv/dt capability

Application

☑ PWM Application
☑ Load Switch
☑ Power Management

Package





Pin description

1	S1
2	D1
3	S2
4	G1
5	D2
6	G2

Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLV8205L	Units
V_{DSS}	Drain-Source Voltage	16	V
I_D	Drain Current - Continuous (T_C = 25℃)	4	A
	- Continuous (T_C = 100℃)	2.4	A
I_{DM}	Drain Current - Pulsed (Note 1)	16	A
V_{GSS}	Gate-Source Voltage	±12	V
P_D	Power Dissipation (T_C = 25℃)	1.25	W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	℃/W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	℃
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	℃

* Drain current limited by maximum junction temperature.

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLV8205L	8205L	SOT23-6	Tape & Reel	3000	180000

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 uA	16	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} =16 V, V_{GS} = 0 V	--	--	1	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 10V, V_{DS} = 0 V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -10V, V_{DS} = 0 V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 uA	0.4		1.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 4.5 V, I_D =4A	--	22	29	mΩ
		V_{GS} = 2.5 V, I_D =2A	--	34	45	
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 8V, V_{GS} = 0V, f = 1.0 MHz	--	227	--	pF
C_{oss}	Output Capacitance		--	67	--	pF
C_{rss}	Reverse Transfer Capacitance		--	65	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{GS}=4.5V, V_{DS}=10V, I_D =1A, R_G =6Ω (Note 2)	--	5	--	ns
t_r	Turn-On Rise Time		--	11	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	32	--	ns
t_f	Turn-Off Fall Time		--	16	--	ns
Q_g	Total Gate Charge	V_{DS} = 10V, I_D =4A, V_{GS} = 4.5V (Note 2)	--	3.8	--	nC
Q_{gs}	Gate-Source Charge		--	0.6	--	nC
Q_{gd}	Gate-Drain Charge		--	1.4	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	4	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	16	A
V_{SD}	Drain to Source Diode Forward Voltage, V_{GS} = 0V, I_{SD} =1A, T_J = 25℃		--	--	1.2	V

Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%

N- Channel Typical Characteristics

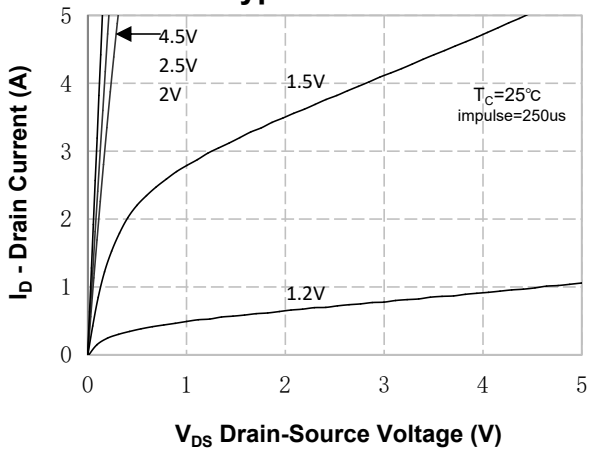


Figure 1. On-Region Characteristics

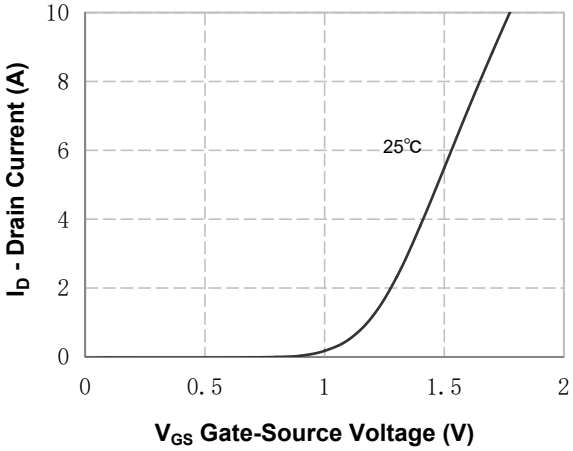


Figure 2. Transfer Characteristics

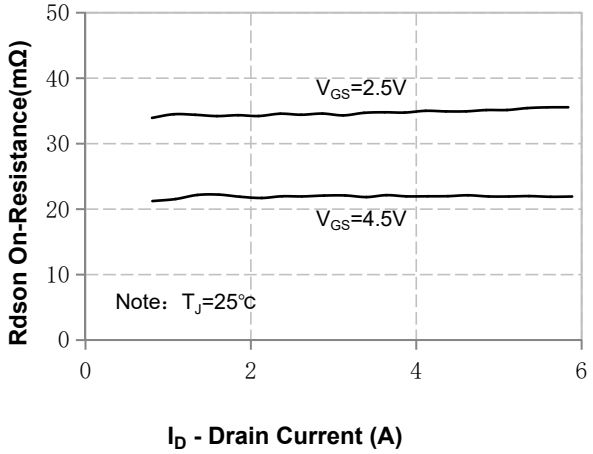


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

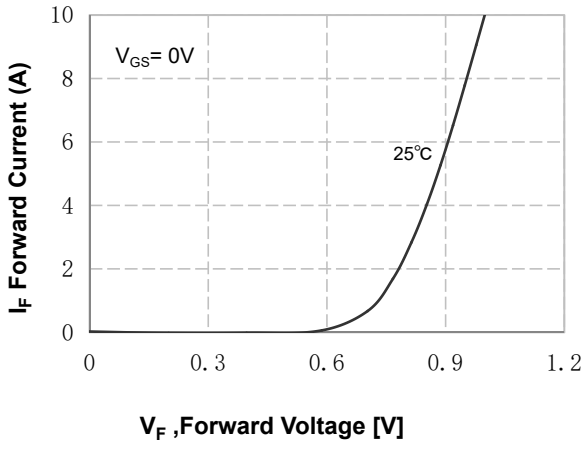


Figure 4. Body Diode Forward Voltage Variation vs Source Current

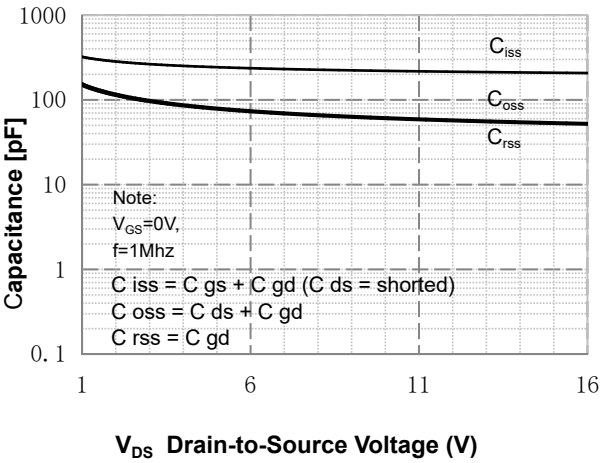


Figure 5. Capacitance Characteristics

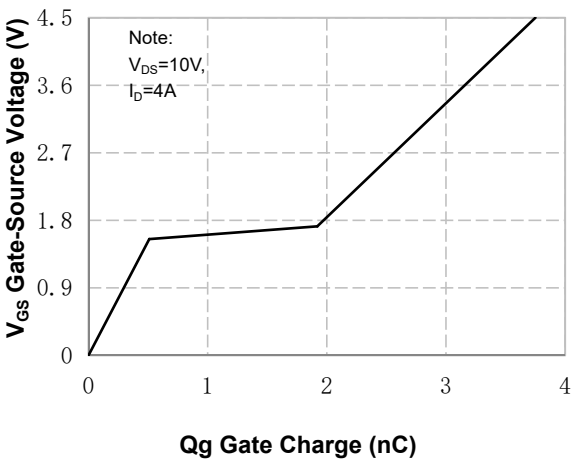


Figure 6. Gate Charge Characteristics

N- Channel Typical Characteristics (Continued)

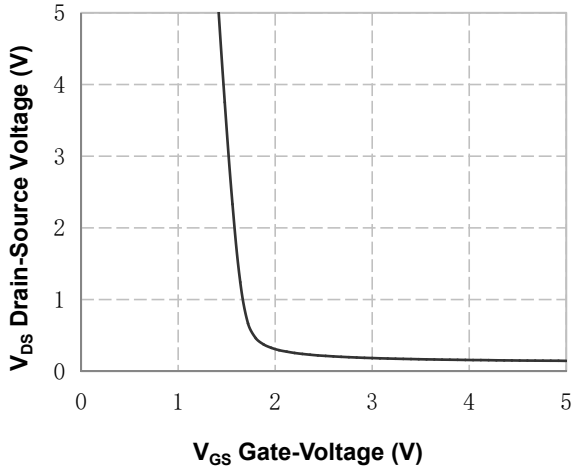


Figure 7. Vds Drain-Source Voltage vs Gate Voltage

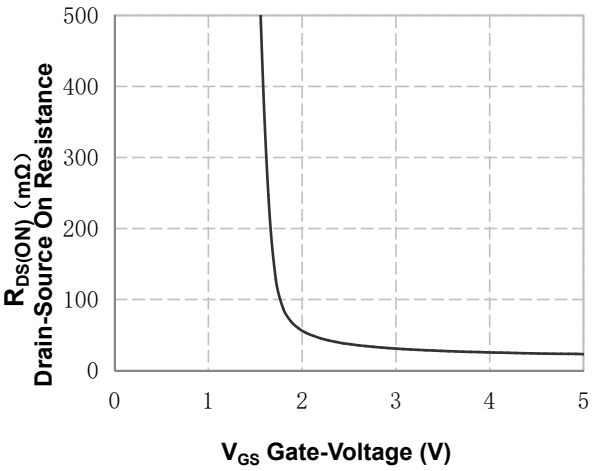


Figure 8. On-Resistance vs Gate Voltage

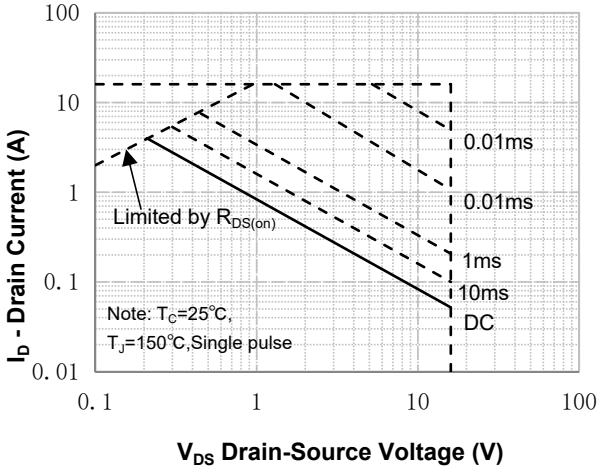


Figure 9. Maximum Safe Operating Area

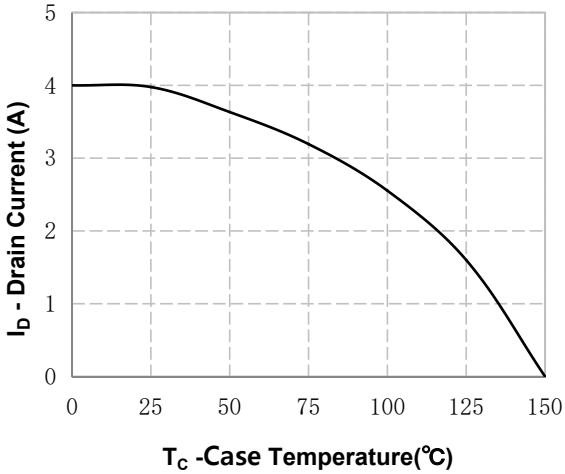


Figure 10. Maximum Continuous Drain Current vs Case Temperature

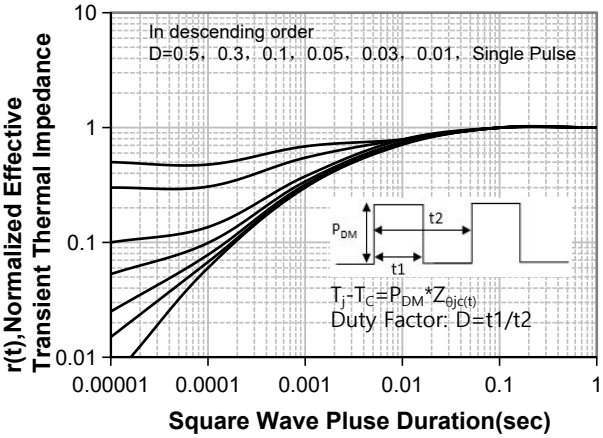
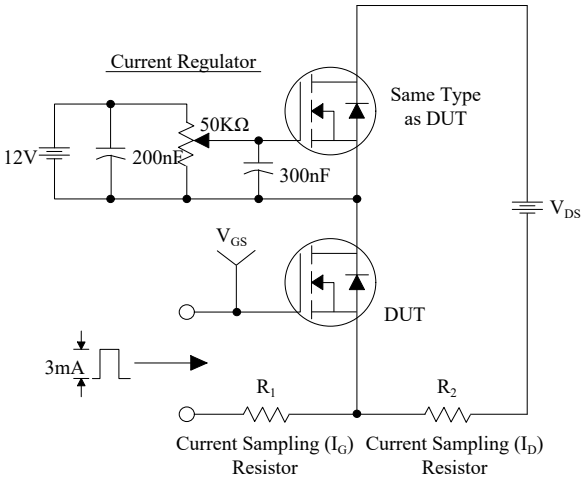
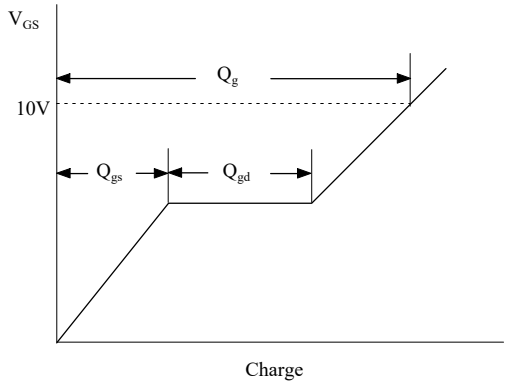


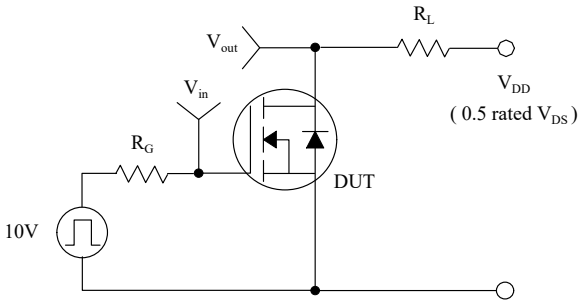
Figure 11. Transient Thermal Response Curve

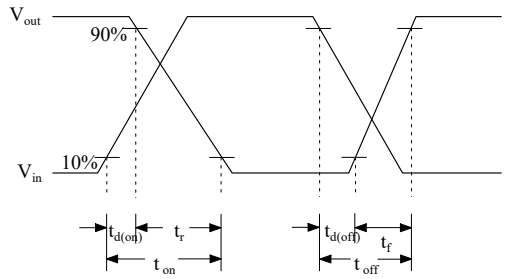
Gate Charge Test Circuit & Waveform



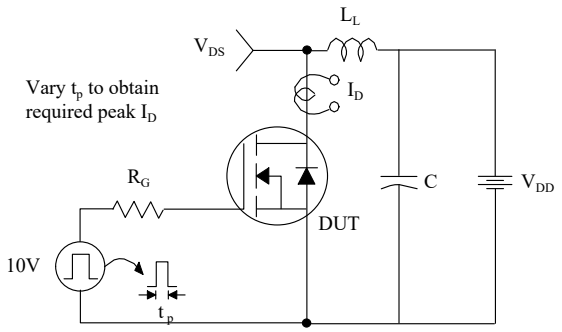


Resistive Switching Test Circuit & Waveforms

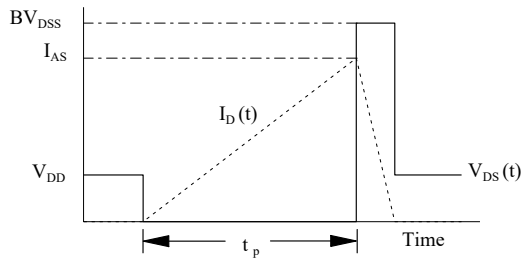




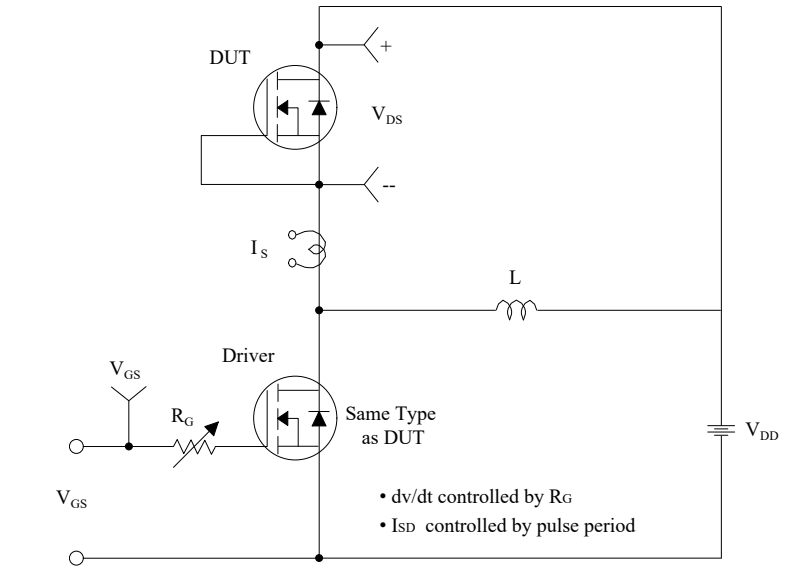
Unclamped Inductive Switching Test Circuit & Waveforms

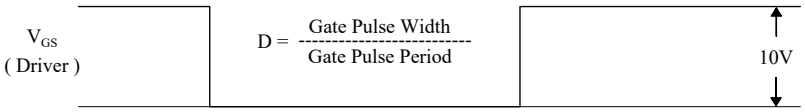


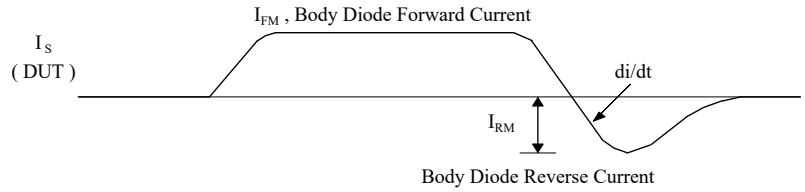
$$E_{AS} = \frac{1}{2} L_L I_{AS}^2$$

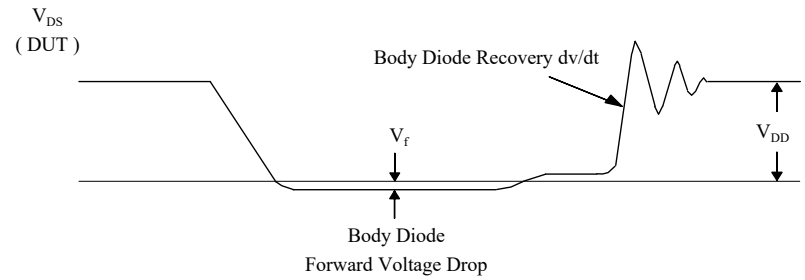


Peak Diode Recovery dv/dt Test Circuit & Waveforms

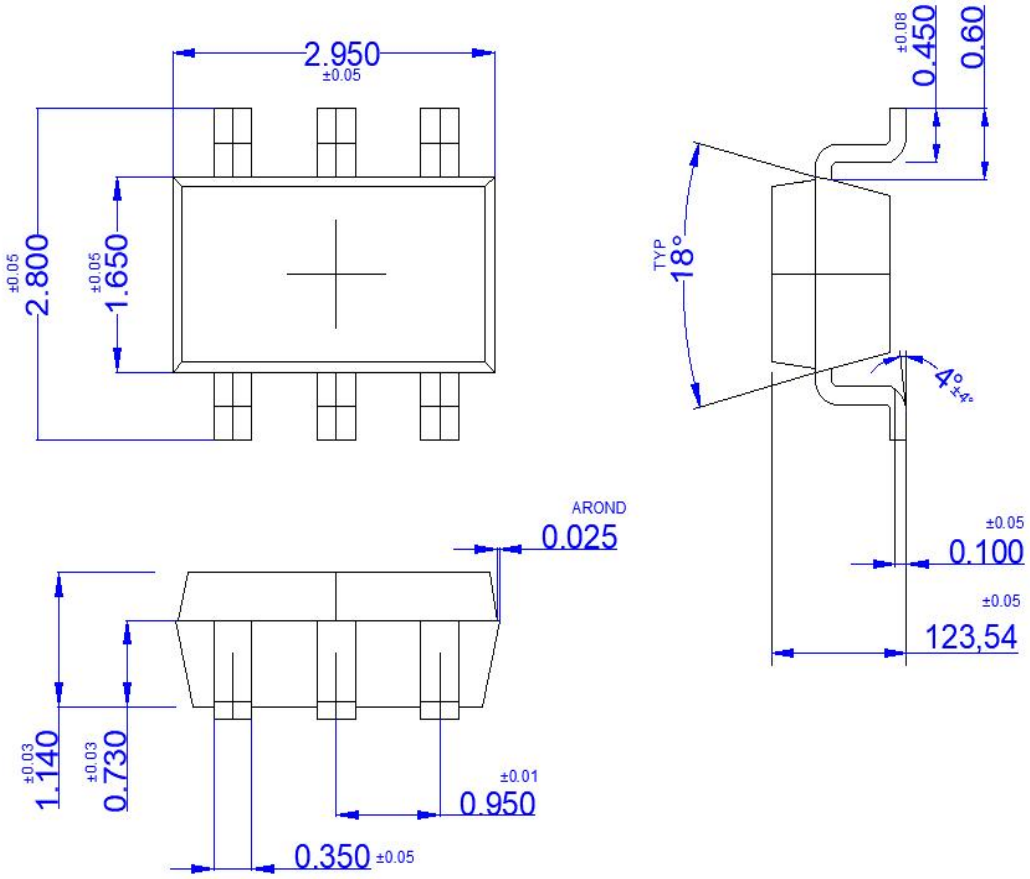








SOT23-6 OUTLINE



NOTE：
1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
2.Undeclared tolerance±0.25,Unmarked filletRmax=0.25

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